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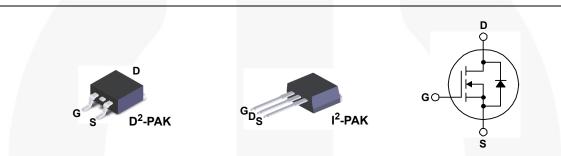
FQB4N80 / FQI4N80 N-Channel QFET[®] MOSFET 800 V, 3.9 A, 3.6 Ω

Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- + 3.9 A, 800 V, ${\sf R}_{\sf DS(on)}$ = 3.6 Ω (Max.) @V_{\sf GS} = 10 V, ${\sf I}_{\sf D}$ = 1.95 A
- Low Gate Charge (Typ. 19 nC)
- Low Crss (Typ. 8.6 pF)
- 100% Avalanche Tested



Absolute Maximum Ratings T_c = 25°C unless otherwise noted.

| Symbol | Parameter | FQB4N80TM / FQI4N80TU | Unit | |
|-----------------------------------|--|-----------------------|------|----|
| V _{DSS} | Drain-Source Voltage | 800 | V | |
| I _D | Drain Current - Continuous (T _C = 25° | 3.9 | А | |
| | - Continuous (T _C = 100 | 2.47 | А | |
| I _{DM} | Drain Current - Pulsed (No | | 15.6 | A |
| V _{GSS} | Gate-Source Voltage | ± 30 | V | |
| E _{AS} | Single Pulsed Avalanche Energy | (Note 2) | 460 | mJ |
| I _{AR} | Avalanche Current (Note | | 3.9 | А |
| E _{AR} | Repetitive Avalanche Energy (Not | | 13 | mJ |
| dv/dt | Peak Diode Recovery dv/dt | 4.0 | V/ns | |
| PD | Power Dissipation $(T_A = 25^{\circ}C)^{*}$ | | 3.13 | W |
| | Power Dissipation ($T_C = 25^{\circ}C$) | 130 | W | |
| | - Derate above 25°C | 1.04 | W/°C | |
| T _J , T _{STG} | Operating and Storage Temperature Rar | -55 to +150 | °C | |
| TL | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | °C |

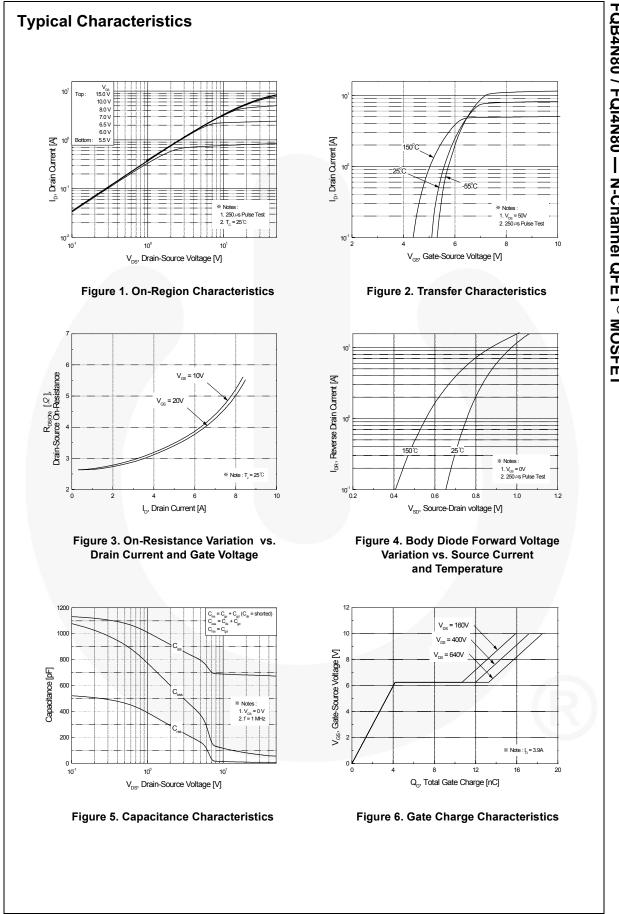
Thermal Characteristics

| Symbol | Parameter | FQB4N80TM FQI4N80TU | Unit | | | |
|----------------|---|------------------------|------|--|--|--|
| R_{\thetaJC} | Thermal Resistance, Junction to Case, Max. 0.96 | | | | | |
| R_{\thetaJA} | Thermal Resistance, Junction to Ambient (minimum pad of 2 oz copper), Max. | 62.5 | °C/W | | | |
| | Thermal Resistance, Junction to Ambient (*1 in ² pad of 2 oz copper), Max. | 40 | | | | |

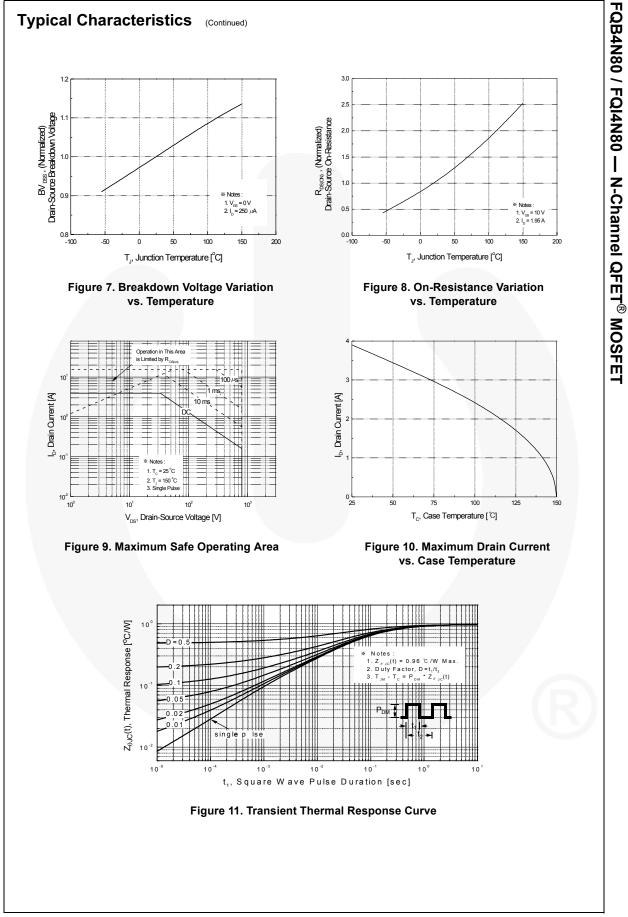
October 2013

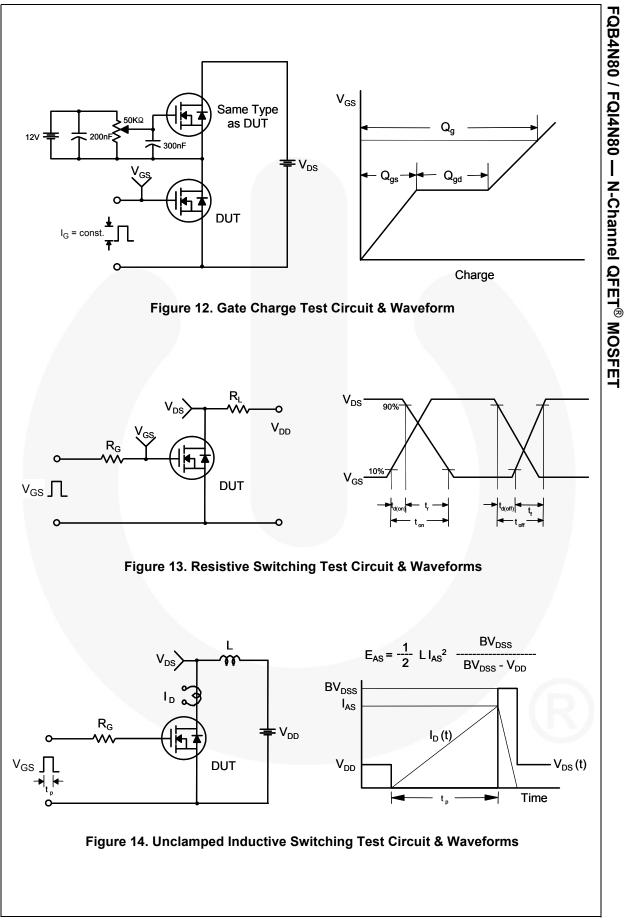
| FQB4N80TM FQB4N80 D ² -F | | | Pack | | Packing Method | | | Tape Width | | Quantity |
|---|---------------------------------|--|---|--|--|----------|-------|------------------|------------------|----------------|
| | | | | Tape and Reel | 330 | | 24 mm | | 800 units | |
| | | PAK Tube N | | N/. | A | N/A | | 50 units | | |
| lectri | cal Ch | aracteristics T | _c = 25°C unl | ess otherv | vise noted. | | | | | |
| Symbol | | Parameter | | | Test Conditions | | Min | Тур | Max | Units |
| Off Cha | aracteri | stics | | | | | , | | , | |
| BV _{DSS} | Drain-S | ource Breakdown Volta | ige | V _{GS} = | 0 V, I _D = 250 μA | | 800 | | | V |
| ΔBV _{DSS} / ΔT _{.1} | Breakdo | own Voltage Temperatu ent | ire | $I_D = 250 \ \mu$ A, Referenced to 25°C | | | 0.95 | | V/°C | |
| I _{DSS} | Zero Gate Voltage Drain Current | | V _{DS} = 800 V, V _{GS} = 0 V | | | | | 10 | μA | |
| | | | | 640 V, T _C = 125°C | | | | 100 | μA | |
| I _{GSSF} | Gate-Bo | ody Leakage Current, F | orward | | 30 V, V _{DS} = 0 V | | | | 100 | nA |
| I _{GSSR} | | ody Leakage Current, F | | | -30 V, V _{DS} = 0 V | | | | -100 | nA |
| | racteri | | | | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | | V _{DS} = V _{GS} , I _D = 250 μA | | 3.0 | | 5.0 | V | | |
| R _{DS(on)} | | rain-Source | | V _{GS} =10V, I _D =1.95A | | | 2.8 | 3.6 | Ω | |
| 9 _{FS} | | rd Transconductance | | V _{DS} = 50 V, I _D = 1.95 A | | | 3.8 | | S | |
| Dynam C _{iss} C _{oss} C _{rss} | Input Ca Output | Characteristics put Capacitance utput Capacitance everse Transfer Capacitance | | V _{DS} = f = 1.0 | 25 V, V _{GS} = 0 V, 9 MHz | | | 680 75 8.6 | 880 100 12 | pF pF pF |
| Switchi | ing Cha | ractoriation | | | | | | | | |
| d(on) | - | Delay Time | - | | | | | 16 | 40 | ns |
| a(on) | | n Rise Time | - | | $V_{DD} = 400 \text{ V}, \text{ I}_{D} = 3.9 \text{ A},$ | | | 45 | 100 | ns |
| d(off) | | f Delay Time | | R _G = 2 | 25 Ω | | | 35 | 80 | ns |
| f | | f Fall Time | | (Note 4) | | (Note 4) | | 35 | 80 | ns |
| Qg | | ate Charge | | V _{DS} = 640 V, I _D = 3.9 A, | | | | 19 | 25 | nC |
| _y ຊ _{gs} | | ource Charge | | V _{DS} = | - | | | 4.2 | | nC |
| Q _{gd} | | ain Charge | | *GS | | (Note 4) | | 9.1 | | nC |
| | | | | | | | | 0.1 | | |
| Drain-S | | Diode Characteris | | | - | _ | | | 3.0 | Δ |
| | | m Pulsed Drain-Source | | | | | | | 3.9 | A |
| SM | | | | | 0 V, I _S = 3.9 A | | | | 15.6 | A |
| V _{SD} | | ource Diode Forward V | onaye | | | | | | 1.4 | |
| t _{rr} | | e Recovery Time | | | _{GS} = 0 V, I _S = 3.9 A, ₌ / dt = 100 A/μs | | | 575 | | ns |
| Q _{rr} | Reverse | e Recovery Charge | | u _F /a | | | | 3.65 | | μC |

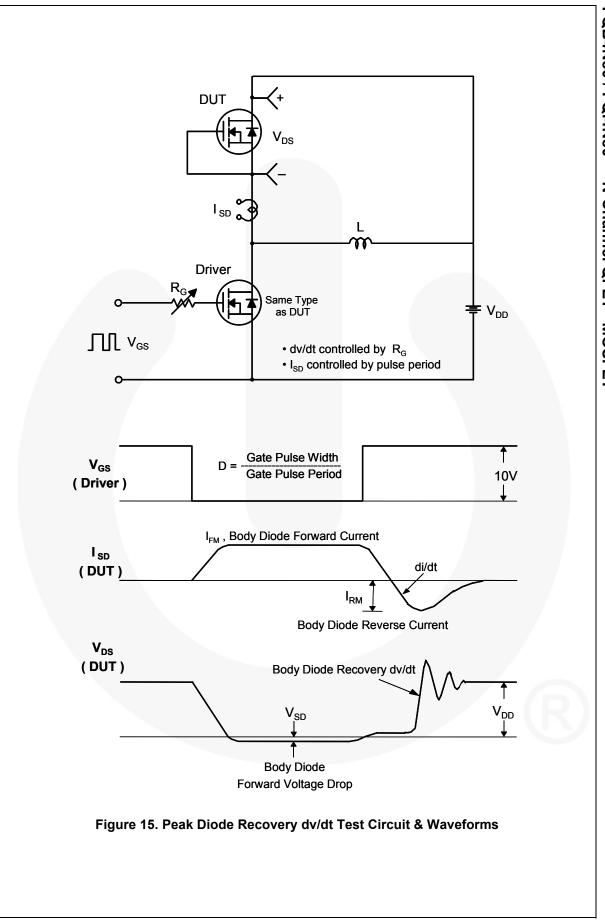
4. Essentially independent of operating temperature

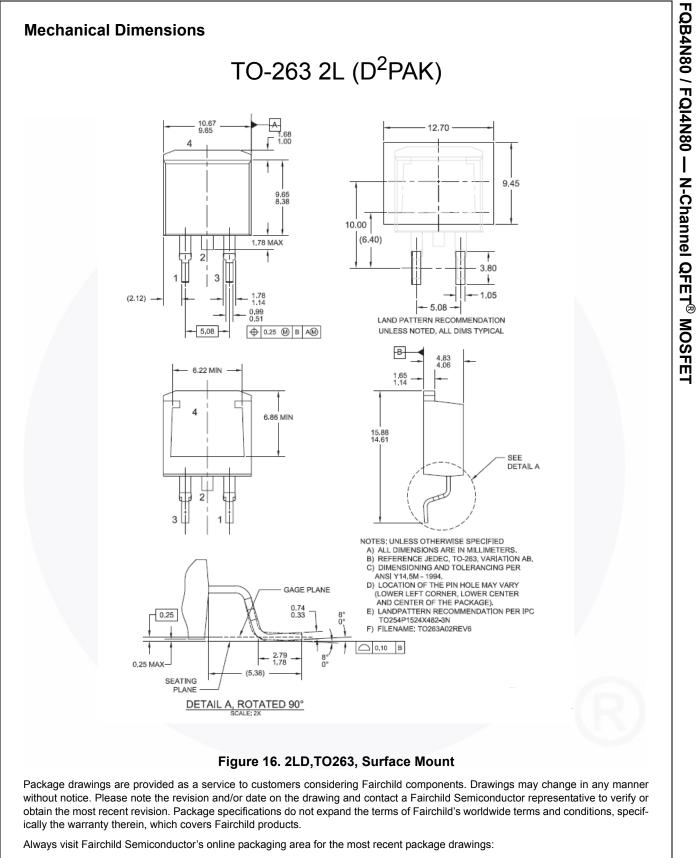


FQB4N80 / FQI4N80 — N-Channel QFET® MOSFET



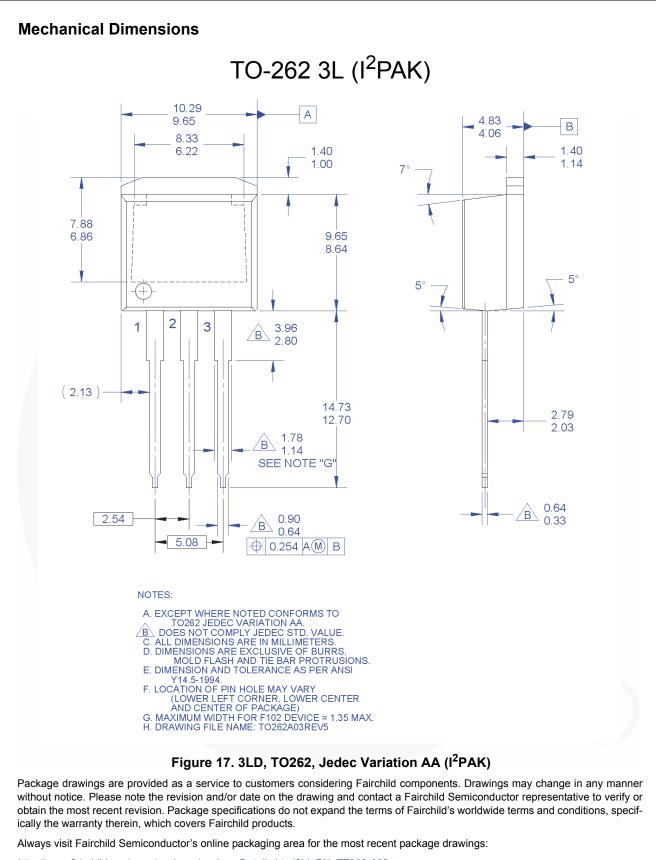






http://www.fairchildsemi.com/package/packageDetails.html?id=PN_TT263-002.

Dimension in Millimeters



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Dimension in Millimeters

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| Preliminary | First Production | date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
|--------------------------|-------------------|---|
| No Identification Needed | Full Production | Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design. |
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Rev. 166

FQB4N80 / FQI4N80 ---

N-Channel QFET[®] MOSFET

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